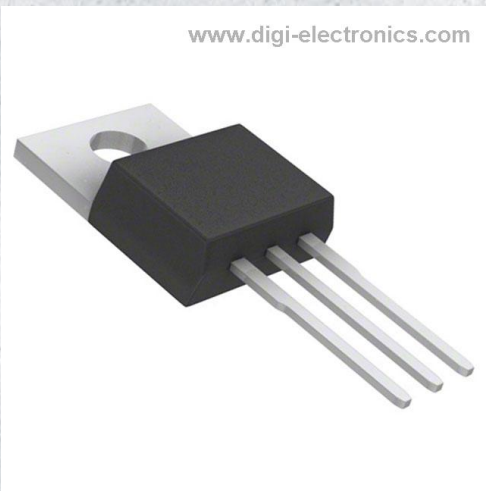
# FQP2N60 Datasheet

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| | |
|---|---|
| DiGi Electronics Part Number | FQP2N60-DG |
| Manufacturer | onsemi |
| Manufacturer Product Number | FQP2N60 |
| Description | MOSFET N-CH 600V 2.4A TO220-3 |
| Detailed Description | N-Channel 600 V 2.4A (Tc) 64W (Tc) Through Hole TO-220-3 |

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RFQ Email: Info@DiGi-Electronics.com

## Purchase and inquiry

| Manufacturer Product Number: | Manufacturer: |
| --- | --- |
| FQP2N60 | onsemi |
| Series: | Product Status: |
| QFET® | Obsolete |
| FET Type: | Technology: |
| N-Channel | MOSFET (Metal Oxide) |
| Drain to Source Voltage (Vdss): | Current - Continuous Drain (Id) @ 25°C: |
| 600 V | 2.4A (Tc) |
| Drive Voltage (Max Rds On, Min Rds On): | Rds On (Max) @ Id, Vgs: |
| 10V | 4.7Ohm @ 1.2A, 10V |
| Vgs(th) (Max) @ Id: | Gate Charge (Qg) (Max) @ Vgs: |
| 4V @ 250µA | 11 nC @ 10 V |
| Vgs (Max): | Input Capacitance (Ciss) (Max) @ Vds: |
| ±30V | 350 pF @ 25 V |
| FET Feature: | Power Dissipation (Max): |
| - | 64W (Tc) |
| Operating Temperature: | Mounting Type: |
| -55°C ~ 150°C (TJ) | Through Hole |
| Supplier Device Package: | Package / Case: |
| TO-220-3 | TO-220-3 |
| Base Product Number: | |
| FQP2 | |

## Environmental & Export classification

| Moisture Sensitivity Level (MSL): | REACH Status: |
| --- | --- |
| 1 (Unlimited) | REACH Unaffected |
| ECCN: | HTSUS: |
| EAR99 | 8541.29.0095 |

FAIRCHILD SEMICONDUCTOR™

April 2000

QFET™

# FQP2N60

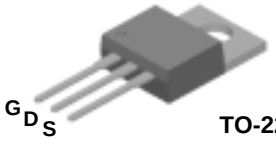
## 600V N-Channel MOSFET

### General Description

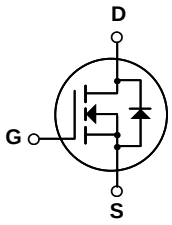
These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.
This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switch mode power supply.

### Features

- 2.4A, 600V, $R_{DS(on)}$ = 4.7Ω @$V_{GS}$ = 10 V
- Low gate charge ( typical 9.0 nC)
- Low Crss ( typical 5.0 pF)
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability




**TO-220**
**FQP Series**




## Absolute Maximum Ratings

$T_C$ = 25°C unless otherwise noted

| Symbol | Parameter | | FQP2N60 | Units |
|---|---|---|---|---|
| $V_{DSS}$ | Drain-Source Voltage | | 600 | V |
| $I_D$ | Drain Current - Continuous ($T_C$ = 25°C) | | 2.4 | A |
| | - Continuous ($T_C$ = 100°C) | | 1.5 | A |
| $I_{DM}$ | Drain Current - Pulsed | (Note 1) | 9.6 | A |
| $V_{GSS}$ | Gate-Source Voltage | | ± 30 | V |
| $E_{AS}$ | Single Pulsed Avalanche Energy | (Note 2) | 140 | mJ |
| $I_{AR}$ | Avalanche Current | (Note 1) | 2.4 | A |
| $E_{AR}$ | Repetitive Avalanche Energy | (Note 1) | 6.4 | mJ |
| dv/dt | Peak Diode Recovery dv/dt | (Note 3) | 4.5 | V/ns |
| $P_D$ | Power Dissipation ($T_C$ = 25°C) | | 64 | W |
| | - Derate above 25°C | | 0.51 | W/°C |
| $T_J$, $T_{STG}$ | Operating and Storage Temperature Range | | -55 to +150 | °C |
| $T_L$ | Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds | | 300 | °C |

## Thermal Characteristics

| Symbol | Parameter | Typ | Max | Units |
|---|---|---|---|---|
| $R_{\theta JC}$ | Thermal Resistance, Junction-to-Case | -- | 1.95 | °C/W |
| $R_{\theta CS}$ | Thermal Resistance, Case-to-Sink | 0.5 | -- | °C/W |
| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient | -- | 62.5 | °C/W |

## Electrical Characteristics

$T_C$ = 25°C unless otherwise noted

| Symbol | Parameter | Test Conditions | Min | Typ | Max | Units |
|---|---|---|---|---|---|---|
| **Off Characteristics** | | | | | | |
| $BV_{DSS}$ | Drain-Source Breakdown Voltage | $V_{GS}$ = 0 V, $I_D$ = 250 µA | 600 | -- | -- | V |
| $\Delta BV_{DSS}$ / $\Delta T_J$ | Breakdown Voltage Temperature Coefficient | $I_D$ = 250 µA, Referenced to 25°C | -- | 0.4 | -- | V/°C |
| $I_{DSS}$ | Zero Gate Voltage Drain Current | $V_{DS}$ = 600 V, $V_{GS}$ = 0 V | -- | -- | 10 | µA |
| | | $V_{DS}$ = 480 V, $T_C$ = 125°C | -- | -- | 100 | µA |
| $I_{GSSF}$ | Gate-Body Leakage Current, Forward | $V_{GS}$ = 30 V, $V_{DS}$ = 0 V | -- | -- | 100 | nA |
| $I_{GSSR}$ | Gate-Body Leakage Current, Reverse | $V_{GS}$ = -30 V, $V_{DS}$ = 0 V | -- | -- | -100 | nA |
| **On Characteristics** | | | | | | |
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{DS}$ = $V_{GS}$, $I_D$ = 250 µA | 3.0 | -- | 5.0 | V |
| $R_{DS(on)}$ | Static Drain-Source On-Resistance | $V_{GS}$ = 10 V, $I_D$ = 1.2 A | -- | 3.7 | 4.7 | Ω |
| $g_{FS}$ | Forward Transconductance | $V_{DS}$ = 50 V, $I_D$ = 1.2 A (Note 4) | -- | 2.45 | -- | S |
| **Dynamic Characteristics** | | | | | | |
| $C_{iss}$ | Input Capacitance | $V_{DS}$ = 25 V, $V_{GS}$ = 0 V, f = 1.0 MHz | -- | 270 | 350 | pF |
| $C_{oss}$ | Output Capacitance | | -- | 40 | 50 | pF |
| $C_{rss}$ | Reverse Transfer Capacitance | | -- | 5 | 7 | pF |
| **Switching Characteristics** | | | | | | |
| $t_{d(on)}$ | Turn-On Delay Time | $V_{DD}$ = 300 V, $I_D$ = 2.4 A, $R_G$ = 25 Ω (Note 4, 5) | -- | 10 | 30 | ns |
| $t_r$ | Turn-On Rise Time | | -- | 25 | 60 | ns |
| $t_{d(off)}$ | Turn-Off Delay Time | | -- | 20 | 50 | ns |
| $t_f$ | Turn-Off Fall Time | | -- | 25 | 60 | ns |
| $Q_g$ | Total Gate Charge | $V_{DS}$ = 480 V, $I_D$ = 2.4 A, $V_{GS}$ = 10 V (Note 4, 5) | -- | 9.0 | 11 | nC |
| $Q_{gs}$ | Gate-Source Charge | | -- | 1.6 | -- | nC |
| $Q_{gd}$ | Gate-Drain Charge | | -- | 4.3 | -- | nC |
| **Drain-Source Diode Characteristics and Maximum Ratings** | | | | | | |
| $I_S$ | Maximum Continuous Drain-Source Diode Forward Current | | -- | -- | 2.4 | A |
| $I_{SM}$ | Maximum Pulsed Drain-Source Diode Forward Current | | -- | -- | 9.6 | A |
| $V_{SD}$ | Drain-Source Diode Forward Voltage | $V_{GS}$ = 0 V, $I_S$ = 2.4 A | -- | -- | 1.4 | V |
| $t_{rr}$ | Reverse Recovery Time | $V_{GS}$ = 0 V, $I_S$ = 2.4 A, $dI_F$ / dt = 100 A/µs (Note 4) | -- | 180 | -- | ns |
| $Q_{rr}$ | Reverse Recovery Charge | | -- | 0.72 | -- | µC |

**Notes:**
1. Repetitive Rating : Pulse width limited by maximum junction temperature
2. L = 45mH, $I_{AS}$ = 2.4A, $V_{DD}$ = 50V, $R_G$ = 25 Ω, Starting $T_J$ = 25°C
3. $I_{SD}$ ≤ 2.4A, di/dt ≤ 200A/µs, $V_{DD}$ ≤ $BV_{DSS}$, Starting $T_J$ = 25°C
4. Pulse Test : Pulse width ≤ 300µs, Duty cycle ≤ 2%
5. Essentially independent of operating temperature

## Typical Characteristics

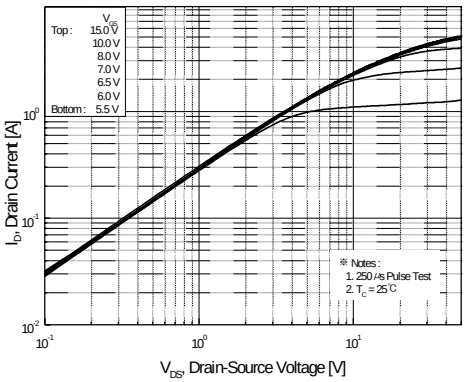



**Figure 1. On-Region Characteristics**

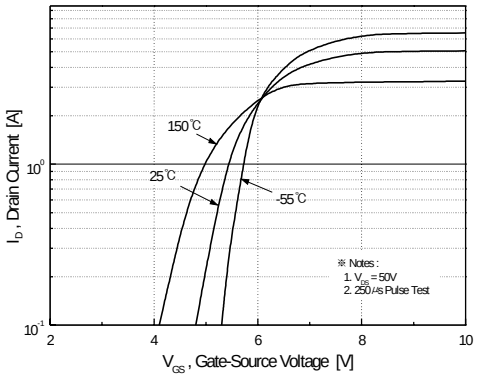



**Figure 2. Transfer Characteristics**

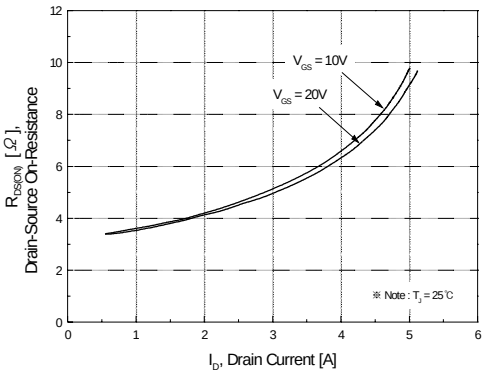



**Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage**

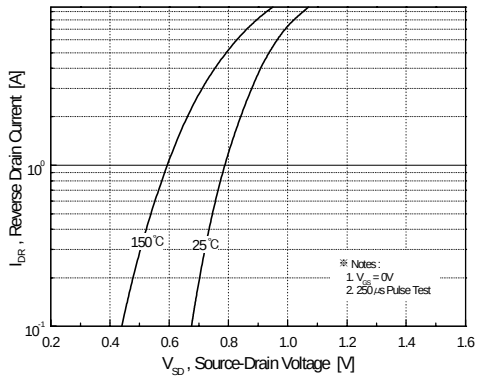



**Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature**

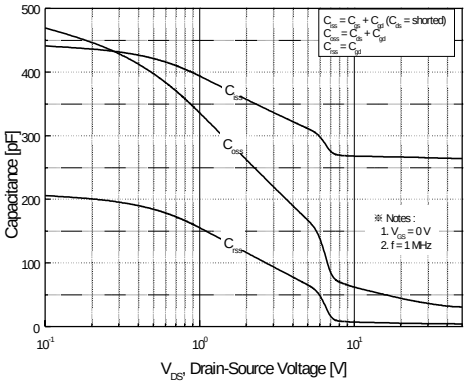



**Figure 5. Capacitance Characteristics**

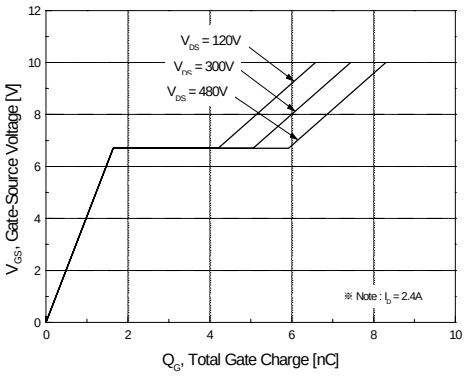



**Figure 6. Gate Charge Characteristics**

## Typical Characteristics (Continued)

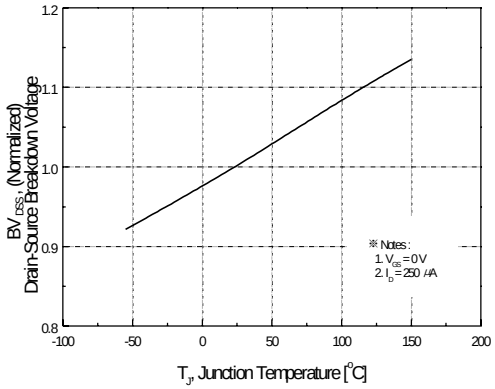



**Figure 7. Breakdown Voltage Variation vs. Temperature**

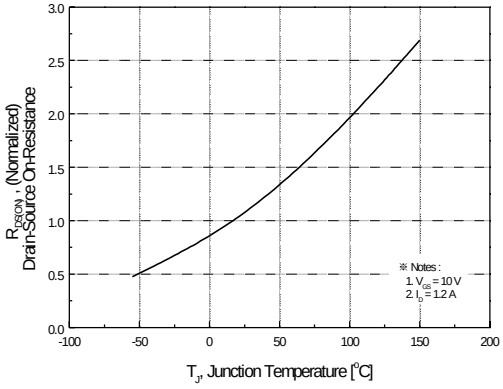



**Figure 8. On-Resistance Variation vs. Temperature**

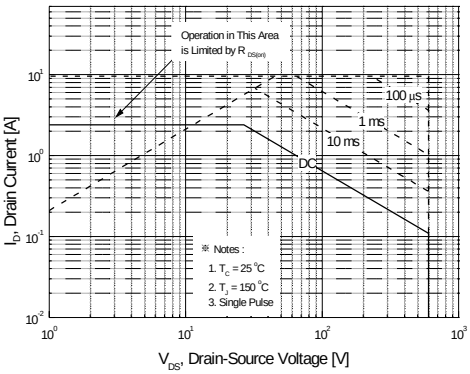



**Figure 9. Maximum Safe Operating Area**

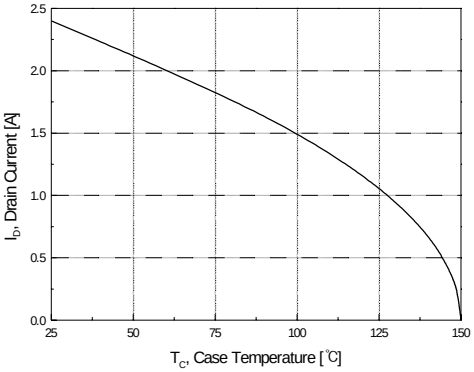



**Figure 10. Maximum Drain Current vs. Case Temperature**

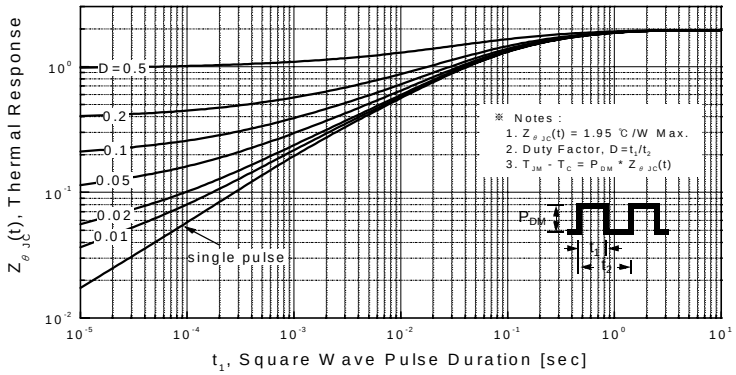
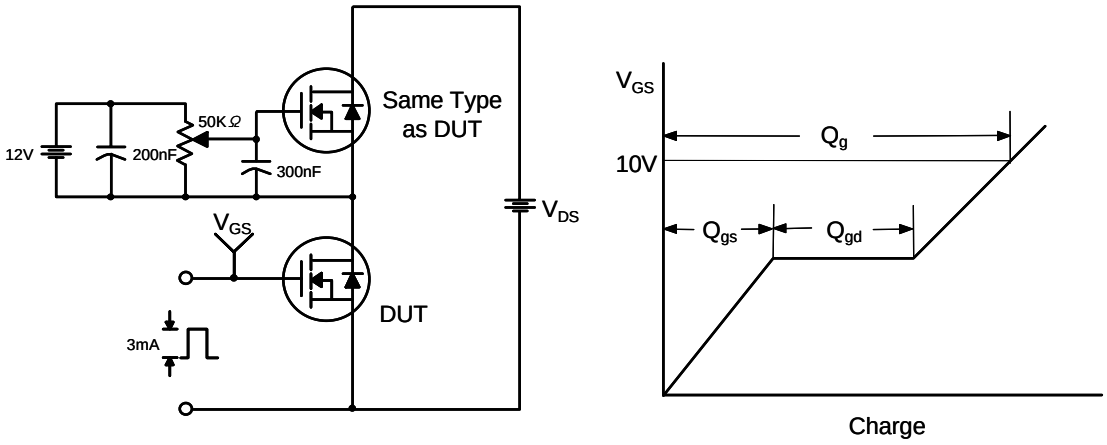
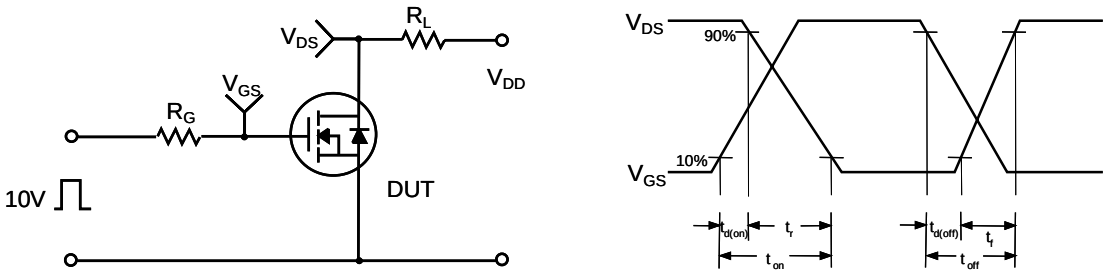



**Figure 11. Transient Thermal Response Curve**

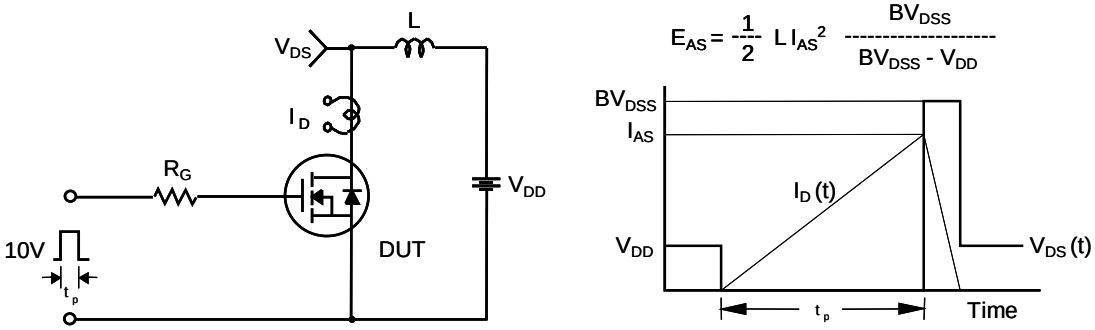
**Gate Charge Test Circuit & Waveform**



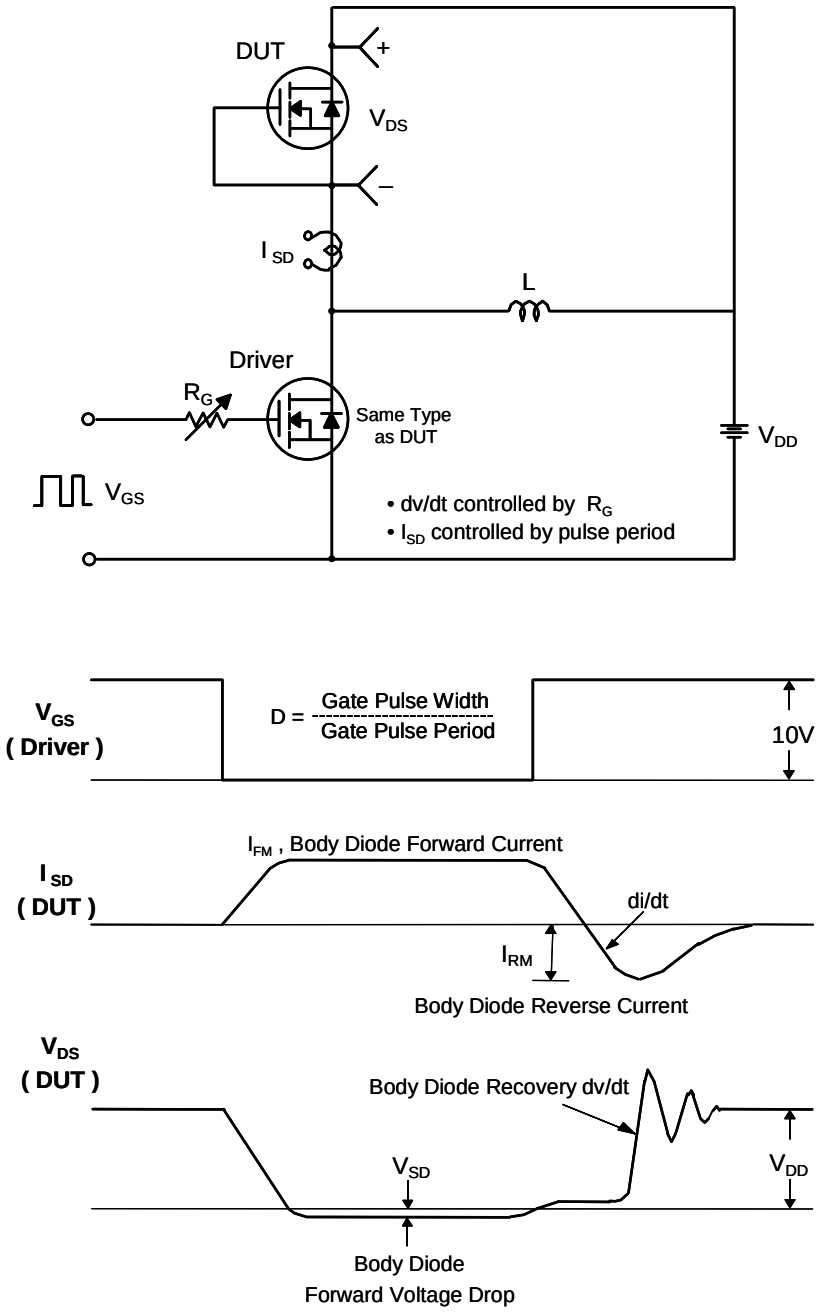

**Resistive Switching Test Circuit & Waveforms**




**Unclamped Inductive Switching Test Circuit & Waveforms**



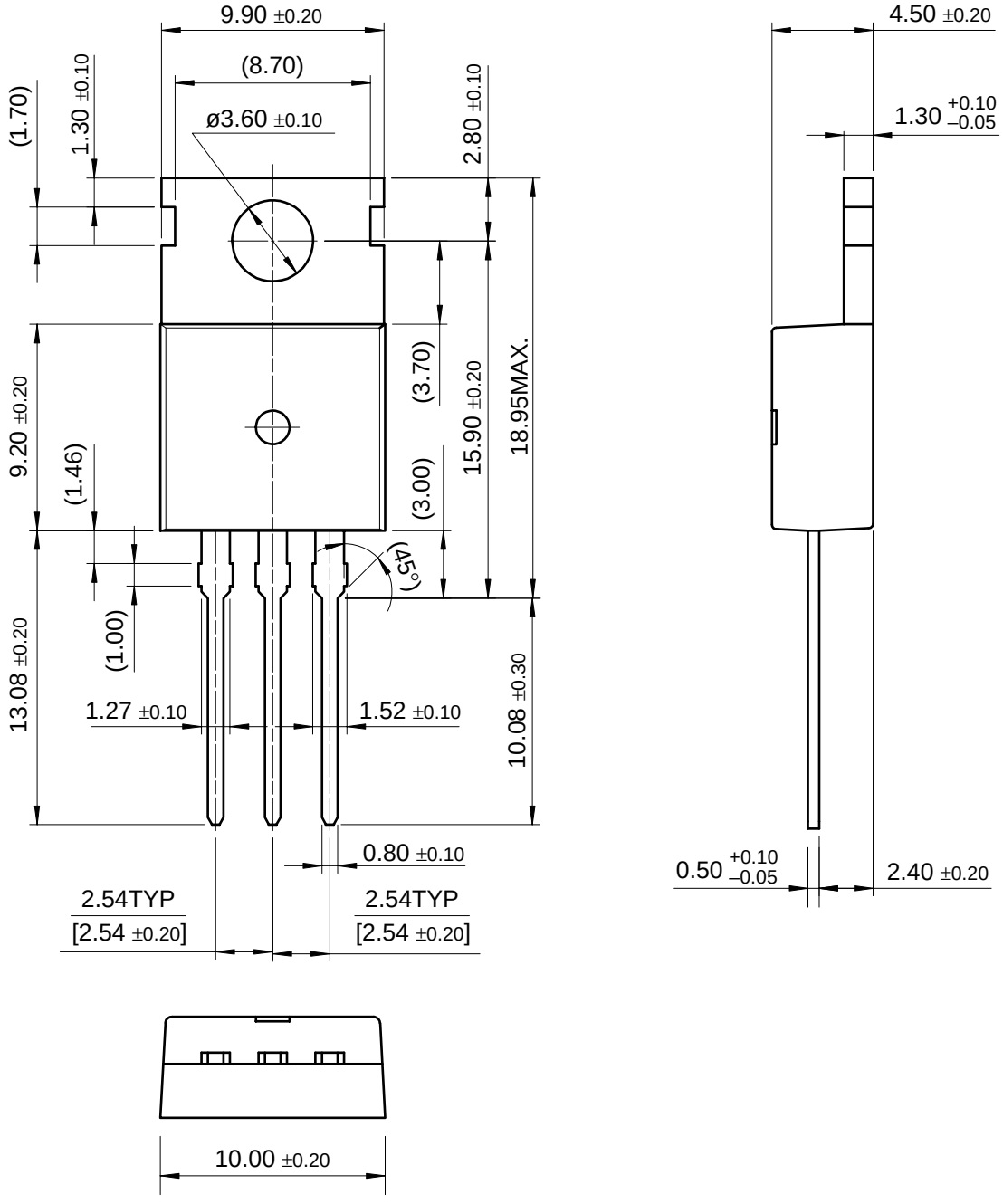
**Peak Diode Recovery dv/dt Test Circuit & Waveforms**



FQP2N60

**Package Dimensions**

# TO-220



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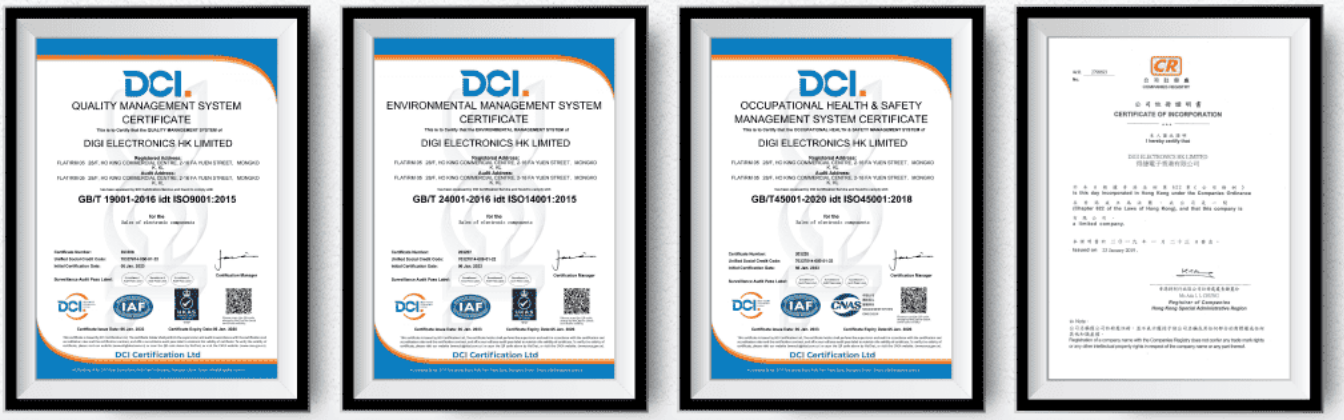



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